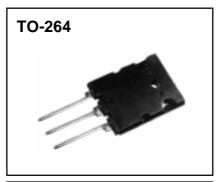
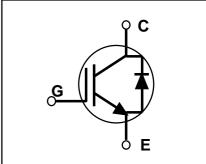
FEATURES

- * Short Circuit rated 10uS @Tc=100°C
- * High Speed Switching
- * Low Saturation Voltage
 - : V_{CF}(sat) = 2.0 V @ Ic=5A
- * High Input Impedance
- * CO-PAK, IGBT with FRD
 - : Trr = 37nS (Typ.)

APPLICATIONS

- * AC & DC Motor controls
- * General Purpose Inverters
- * Robotics, Servo Controls
- * Power Supply
- * Lamp Ballast





ABSOLUTE MAXIMUM RATINGS

Symbol	Characteristics	Rating	Units
V _{CES}	Collector-Emitter Voltage	600	V
V_{GES}	Gate-Emitter Voltage	±20	V
I _C	Collector Current @ Tc = 25°C	8	Α
	Collector Current @ Tc = 100°C	5	Α
I _{CM (1)}	Pulsed Collector Current	15	А
I _F	Diode Continuous Forward Current @ Tc = 100°C	8	Α
I _{FM}	Diode Maximum Forward Current	56	А
P _D	Maximum Power Dissipation @Tc = 25°C	60	W
	Maximum Power Dissipation @Tc = 100°C	25	W
Tsc	Short Circuit Withstand Time	10	uS
Tj	Operating Junction Temperature	-55 ~ 150	°C
Tstg	Storage Temperature Range	-55 ~ 150	°C
TL	Maximum Lead Temp. For Soldering	300	°C
	Purposes, 1/8" from case for 5 seconds		

Notes: (1) Repetitive rating : Pulse width limited by max. junction temperature



SGL5N60RUFD

ELECTRICAL CHARACTERISTICS (IGBT PART) (Tc=25°C,Unless Otherwise Specified)

Symbol	Characteristics	Test Conditions	Min	Тур	Max	Units
BV _{CES}	C - E Breakdown Voltage	V _{GE} = 0V , I _C = 250uA	600	-	-	V
$\Delta V_{\text{CES}/}$	Temperature Coeff. of	$V_{GE} = 0V$, $I_C = 1mA$	-	0.6	-	V/°C
ΔT_J	Breakdown Voltage					
$V_{GE(th)}$	G - E threshold voltage	$I_C = 5mA$, $V_{CE} = V_{GE}$	5.0	6.0	8.0	V
I _{CES}	Collector cutoff Current	$V_{CE} = V_{CES}$, $V_{GE} = 0V$	-	-	250	uA
I _{GES}	G - E leakage Current	$V_{GE} = V_{GES}$, $V_{CE} = 0V$	-	-	100	nA
V _{CE} (sat)	Collector to Emitter	Ic=5A, V _{GE} = 15V	-	2.0	2.7	V
	saturation voltage	Ic=8A, V _{GE} = 15V	-	2.5	-	V
Cies	Input capacitance	V _{GE} = 0V , f = 1MHz	-	337	-	pF
Coes	Output capacitance	V _{CE} = 30V	-	60	-	pF
Cres	Reverse transfer capacitance		-	13	-	pF
td(on)	Turn on delay time	$V_{CC} = 300V$, $I_{C} = 5A$	-	9	-	nS
tr	Turn on rise time	V _{GE} = 15V	-	18	-	nS
td(off)	Turn off delay time	$R_{G} = 40\Omega$	-	46	75	nS
tf	Turn off fall time	Inductive Load	-	140	280	nS
Eon	Turn on Switching Loss		-	80	-	uJ
Eoff	Turn off Switching Loss		-	100	-	uJ
Ets	Total Switching Loss		-	180	270	uJ
Tsc	Short Circuit withstand Time	Vcc = 300V, V _{GE} = 15V	10	-	-	uS
		@Tc = 100°C				
Qg	Total Gate Charge	Vcc = 300V	-	24	36	nC
Qge	Gate-Emitter Charge	V _{GE} = 15V	-	7	10	nC
Qgc	Gate-Collector Charge	Ic = 5A	-	8	12	nC



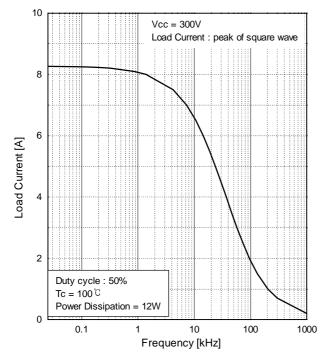
ELECTRICAL CHARACTERISTICS (DIODE PART) (Tc=25°C,Unless Otherwise Specified)

Symbol	Characteristics	Test Conditions		Min	Тур	Max	Units
VFM	Diode Forward Voltage	IF=8.0A	Tc =25°C	-	1.4	1.7	٧
			Tc =100°C	1	1.3	-	
Trr	Diode Reverse		Tc =25°C	- 1	37	55	nS
	Recovery Time		Tc =100°C	ı	55	-	
Irr	Diode Peak Reverse	IF=8.0A, VR=200V	Tc =25°C	ı	3.5	5.0	Α
	Recovery Current	-di/dt=200A/uS	Tc =100°C	-	4.5	-	
Qrr	Diode Reverse		Tc =25°C	ı	65	138	nC
	Recovery Charge		Tc =100°C	ı	124	-	

THERMAL RESISTANCE

Symbol	Characteristics	Min	Тур	Max	Units
R _θ JC	Junction-to-Case (IGBT)	-	-	2.0	°C/W
R _e JC	Junction-to-Case (DIODE)	-	-	3.5	°C/W
R _e JA	Junction-to-Ambient	-	-	25	°C/W
R _e CS	Case-to-Sink	-	0.2	-	°C/W





30 25 20 Tc = 25° Tc = 100°C 10 5 0 0 2 4 6 8 10 Vce [V]

Fig.1 Typical Load Current vs. Frequency

Fig.2 Typical Output Characteristics

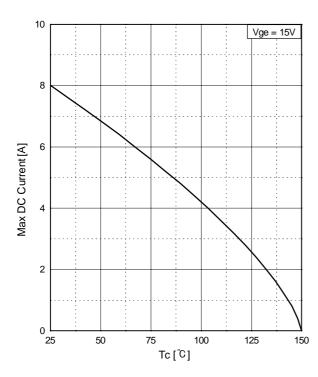


Fig.3 Maximum Collector Current vs. Case Temperature

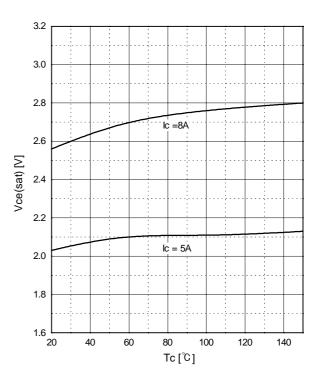


Fig.4 Collector to Emitter Voltage vs. Case Temperature



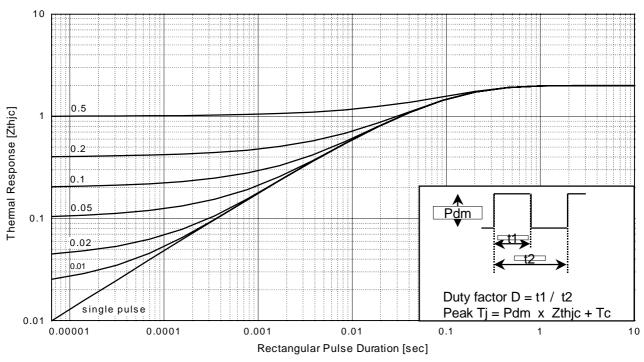


Fig.5 Maximum Effective Transient Thermal Impedance, Junction to Case

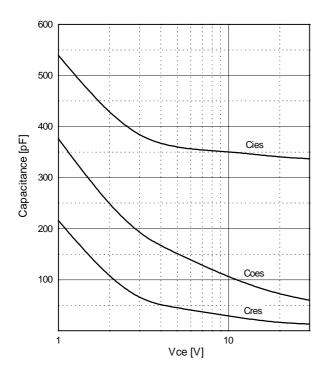


Fig.6 Typical Capacitance vs.
Collector to Emitter Voltage

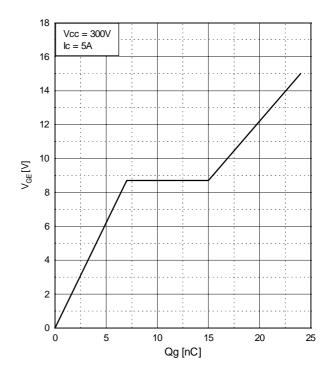


Fig.7 Typical Gate Charge vs. Gate to Emitter Voltage



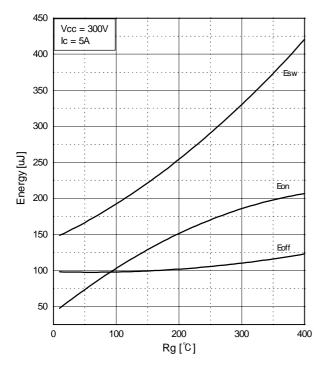


Fig.8 Typical Switching Loss vs. Gate Resistance

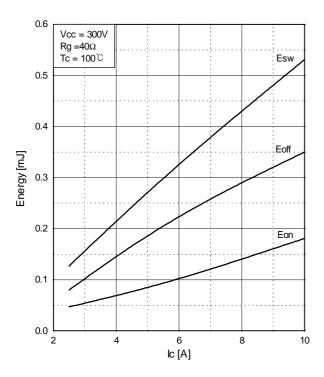


Fig.10 Typical Switching loss vs.
Collector to Emitter Current

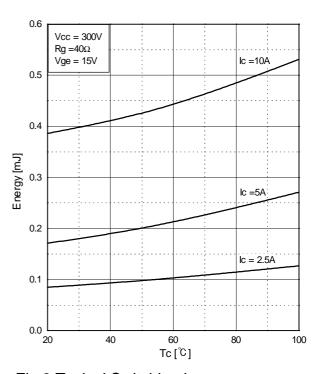


Fig.9 Typical Switching Loss vs. Case Temperature

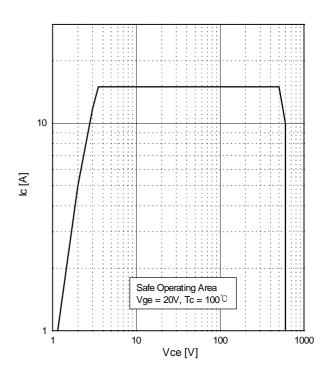


Fig.11 Turn-off SOA



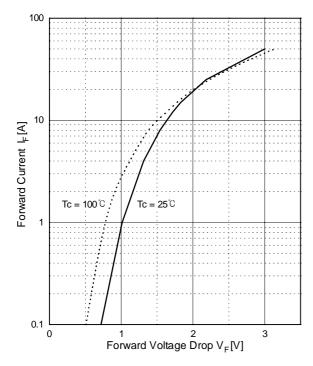


Fig.12 Typical Forward Voltage Drop vs. Forward Current

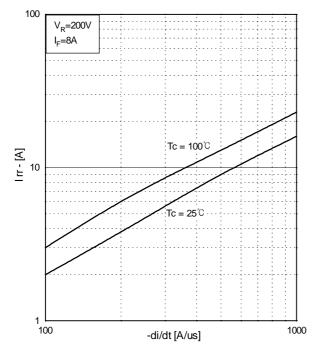


Fig.14 Typical Reverse Recovery Current vs. di/dt

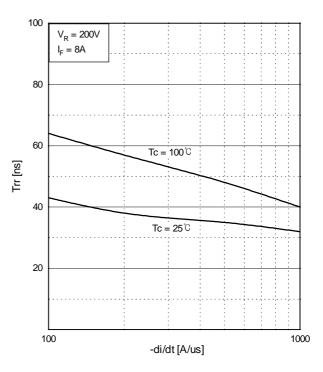


Fig.13 Typical Reverse Recovery Time vs. di/dt

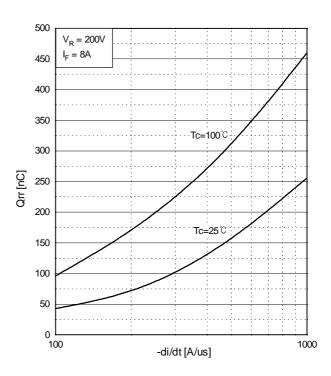


Fig.15 Typical Stored Charge vs. di/dt



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